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Integrating Process Management Technology with Sensor Data

Guest Editors:

Message from the Guest Editors

Prof. Dr. Rüdiger Pryss

Dear Colleagues,

Prof. Dr. Massimo Mecella

Prof. Samir Tata

Prof. Dr. Manfred Reichert

The aim of this Special Issue is to investigate upcoming challenges, research opportunities, and technologies emerging along the described trends. In particular, the Special Issue shall investigate:

Deadline for manuscript submissions:

closed (30 June 2019)

- The impact of considering sensor data on the various stages of the business process lifecycle, i.e., modeling, implementation and configuration, deployment, enactment, monitoring, dynamic adaptation, mining and evolution of business processes.
- The impact of considering business processes on the way sensors systems and networks are built or reorganized.

This Special Issue aims to provide a comprehensive overview of state-of-the-art sensor technology in the light of business process management. We invite research articles that will consolidate the understanding of the state-of-the-art in this area













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Editor-in-Chief

Prof. Dr. Vittorio M. N. Passaro

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Message from the Editor-in-Chief

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